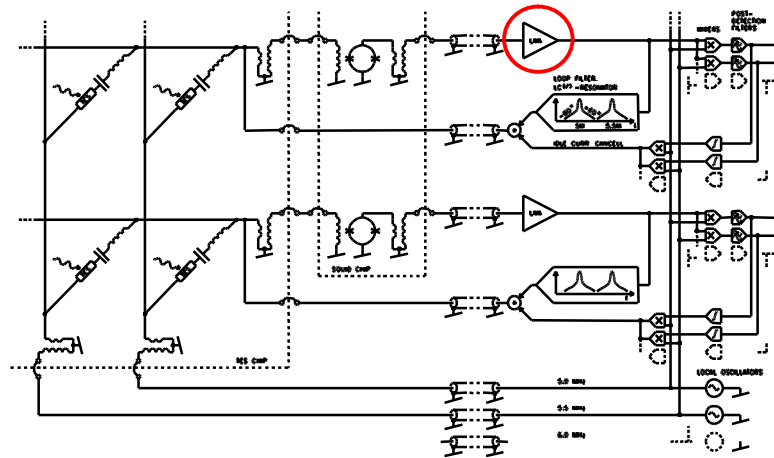


# An ac-coupled post-SQUID semiconductor amplifier

Mikko Kiviranta, (\*) Antti Virtanen, Heikki Seppä, Jari S. Penttilä, Juha Hassel and Panu Helistö  
 VTT Microsensing, 02150 Espoo, Finland; and (\*) GE Healthcare Technologies, 04301 Tuusula, Finland

## Motivation: frequency-domain multiplexing

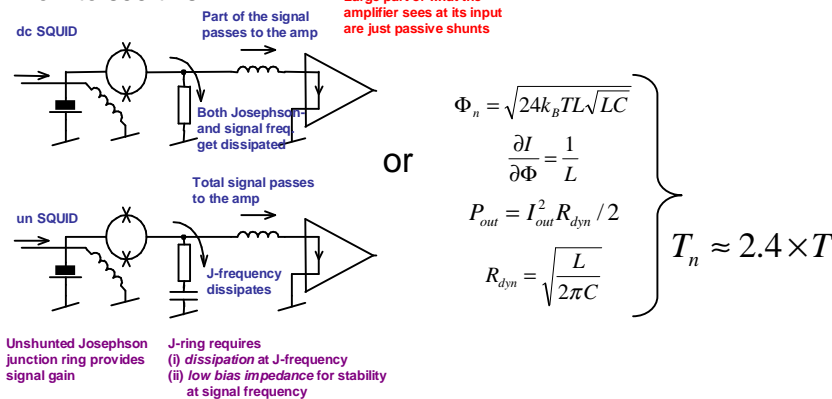


Noise temperature  $T_n = \frac{u_n i_n}{2k_B}$       Noise matching resistance  $Z_n = \frac{u_n}{i_n}$

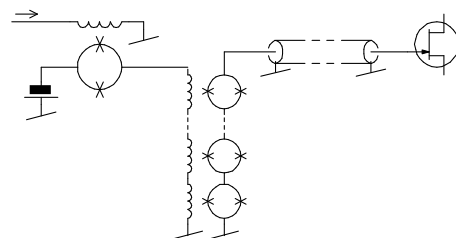
$\leftarrow V / \text{Hz}^{1/2}$   
 $\leftarrow A / \text{Hz}^{1/2}$

## At SQUID output $T_n \sim 2.5 \times$ bath temperature

How to see this:



- Single SQUID at 4.2K:  $T_n \sim 10K$  room-temp amplifier doable but difficult
- SQUID array at 4.2K: same  $T_n$  as single SQUID, just different  $R_n$
- Single SQUID at 0.4K:  $T_n \sim 1K$  room-temp amplifier very difficult
- Single SQUID read with single SQUID: 2nd SQUID limits dynamic range
- Single SQUID read with a  $k$ -SQUID array:
  - Choose coupling such that one  $\Phi_0$  in 1st SQUID corresponds to  $\Phi_0$  in each SQUID in the array
  - Then the dominant non-linearity is the same for 1st and 2nd SQUID...
  - ...but  $T_n$  at the array output is  $k$  times the  $T_n$  at the 1st SQUID output.



## Candidates for the semiconductor device

Bipolar transistors

$$u_n = \sqrt{4k_B T R_{BB}}$$

$$i_n = \sqrt{\frac{2eI_C}{h_{fe}}}$$

$$u_n = \sqrt{\frac{2e}{I_C} \times \frac{kT}{e}}$$

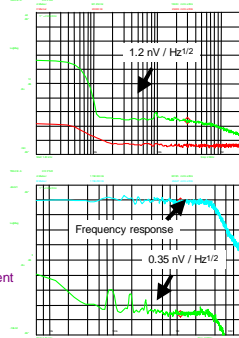
SSM2220, MAT03, AD797: regularly used

FZT690: very large  $h_{fe} \sim 1400$

Not promising

BFP650: very low  $R_{BB} \sim 1 \Omega$

$T_n \sim 50 K$ ,  $Z_n \sim 90 \Omega$ , High-bandwidth replacement for SSM2220, MAT03



JFETs

$$u_n = \sqrt{\frac{8k_B T}{g_m}}$$

$$i_n = \omega C_s \sqrt{\frac{k_B T}{g_m}}$$

$$i_n = \sqrt{2eI_g}$$

$$T_n = \sqrt{2/3} \omega \frac{C_s}{g_m} T$$

2SK147, IF1320: has been used previously

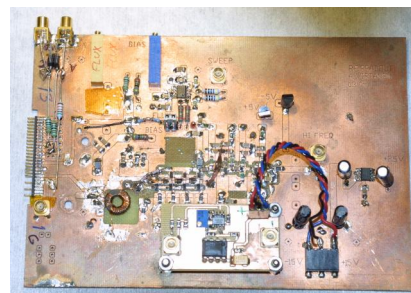
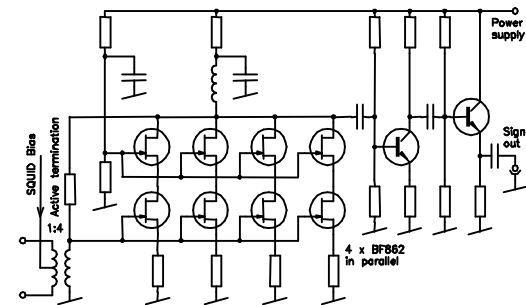
- The largest  $C_g - g_m$  ratio we found: BF862
- $T_n = 5.5 K$ ,  $Z_n = 4.2 k\Omega$  @ 10 MHz (theory)
- Must couple devices in parallel, use transformer to match source resistance

HEMTs / MESFETs

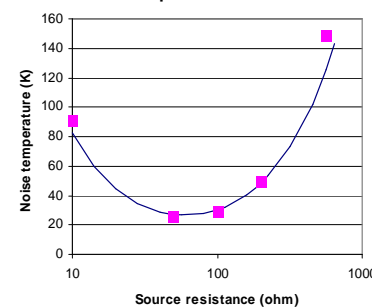
- Tend to have too high 1/f noise corner (100 MHz or more)

## Our JFET amplifier prototype

Simplified schematics

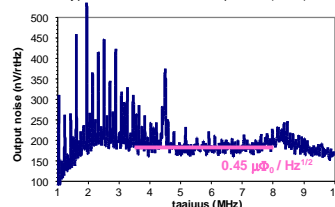


## Noise temperature at 5 MHz



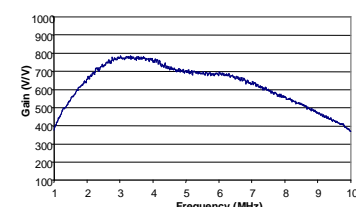
## Noise spectrum with a SQUID

Washer type SQUID, SUST vol.17 p.S285 (2004)



## Frequency response

-3dB bandwidth 1.8 - 9.9 MHz

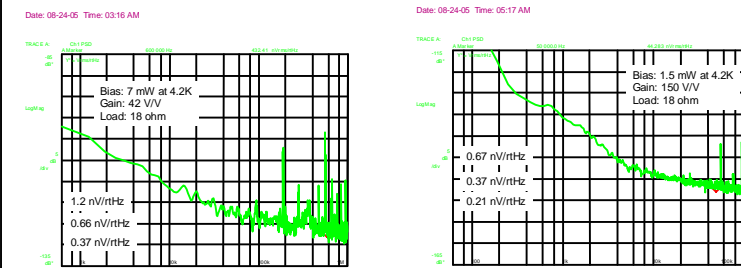


## What about a cryogenic amplifier?

- Short feedback to the SQUID input  $\Rightarrow$  large dynamic range at a large bandwidth
- Johnson noise from cabling becomes negligible

## We have some promising 4.2K results

A quick functionality check for semiconductor device D2



A quick functionality check for semiconductor device D5

- 7 mW bias point
  - 3 MHz cutoff due to cable capacitance
  - With matched circuits > 1 GHz bandwidth feasible
  - Theoretical estimate for current noise 3 pA/rtHz. Observed load dependence is consistent with  $u_n = 0.135 \text{ nV/rtHz}$ ,  $i_n = 4 \text{ pA/rtHz}$ .
  - Getting rid of the 250 kHz interference may lead to lower noise.
- 1.5 mW bias point
  - Lower cutoff, due to higher cable-driving impedance

